

# **MOSFET** - Power, Single **N-Channel**

80 V, 6.2 mΩ, 77 A

## **NVMFS6H836NL**

#### **Features**

- Small Footprint (5x6 mm) for Compact Design
- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Q<sub>G</sub> and Capacitance to Minimize Driver Losses
- NVMFS6H836NLWF Wettable Flank Option for Enhanced Optical Inspection
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free, Halide Free, and are RoHS Compliant

#### MAXIMUM RATINGS (T<sub>.J</sub> = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			$V_{DSS}$	80	V
Gate-to-Source Voltage	)		$V_{GS}$	±20	٧
Continuous Drain	Steady State	T <sub>C</sub> = 25°C	I <sub>D</sub>	77	Α
Current R <sub>0JC</sub> (Notes 1, 3)	State	T <sub>C</sub> = 100°C		55	
Power Dissipation	T <sub>C</sub> = 25°C		$P_{D}$	89	W
R <sub>θJC</sub> (Note 1)		T <sub>C</sub> = 100°C		45	
Continuous Drain	Steady T <sub>A</sub> = 25°C		I <sub>D</sub>	16	Α
Current R <sub>0JA</sub> (Notes 1, 2, 3)	State	T <sub>A</sub> = 100°C		11	
Power Dissipation	T <sub>A</sub> = 25°C		$P_{D}$	3.7	W
H <sub>θJA</sub> (Notes 1, 2)	R <sub>0JA</sub> (Notes 1, 2)			1.8	
Pulsed Drain Current	$T_A = 25$	°C, t <sub>p</sub> = 10 μs	I <sub>DM</sub>	449	Α
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	–55 to + 175	°C
Source Current (Body Diode)			I <sub>S</sub>	74	Α
Single Pulse Drain-to-Source Avalanche Energy (I <sub>L(pk)</sub> = 4.6 A)			E <sub>AS</sub>	653	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

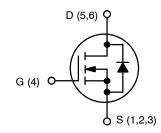
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

#### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State	$R_{ heta JC}$	1.7	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	40.7	

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 650 mm<sup>2</sup>, 2 oz. Cu pad.
- Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
80 V	6.2 mΩ @ 10 V	77 A
	7.8 mΩ @ 4.5 V	117



**N-CHANNEL MOSFET** 

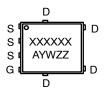


DFN5 (SO-8FL) CASE 488AA STYLE 1



**DFNW5 5x6** (FULL-CUT SO8FL WF) CASE 507BA

#### MARKING DIAGRAM



XXXXXX = 6H836L

(NVMFS6H836NL) or

836LWF

(NVMFS6H836NLWF)

= Assembly Location Α

= Year W = Work Week 77

= Lot Traceability

#### **ORDERING INFORMATION**

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

## **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Co	ondition	Min	Тур	Max	Unit
OFF CHARACTERISTICS				•	•		•
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 2	250 μA	80			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /				46.2		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{GS} = 0 \text{ V},$ $T_{J} = 25^{\circ}\text{C}$				10	μΑ
		V <sub>DS</sub> = 80 V	T <sub>J</sub> = 125°C			100	1
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> =	= 20 V			100	nA
ON CHARACTERISTICS (Note 4)	•						
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D =$	95 μΑ	1.2		2.0	V
Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				-5.2		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 15 A		5.1	6.2	mΩ
		V <sub>GS</sub> = 4.5 V	I <sub>D</sub> = 15 A		6.2	7.8	mΩ
Forward Transconductance	9FS	V <sub>DS</sub> =8 V, I <sub>D</sub> = 40	O A		99		S
CHARGES, CAPACITANCES & GATE RE	SISTANCE						
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 40 V			1950		pF
Output Capacitance	C <sub>OSS</sub>				250		
Reverse Transfer Capacitance	C <sub>RSS</sub>				11		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 40 V; I <sub>D</sub> = 40 A			34		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 40 V; I <sub>D</sub> = 40 A			3		
Gate-to-Source Charge	Q <sub>GS</sub>				6.3		1
Gate-to-Drain Charge	$Q_GD$				5.5		
Plateau Voltage	$V_{GP}$	]			3.0		V
Total Gate Charge	Q <sub>G(TOT)</sub>				16		nC
SWITCHING CHARACTERISTICS (Note	5)			•	•		•
Turn-On Delay Time	t <sub>d(ON)</sub>	$V_{GS} = 4.5 \text{ V}, V_{DS}$	s = 64 V,		40		ns
Rise Time	t <sub>r</sub>	$I_D = 40 \text{ A}, R_G = 2.5 \Omega$			125		1
Turn-Off Delay Time	t <sub>d(OFF)</sub>				26		1
Fall Time	t <sub>f</sub>	1			8		1
DRAIN-SOURCE DIODE CHARACTERIS	STICS						
Forward Diode Voltage	$V_{SD}$	$V_{GS} = 0 V$ ,	T <sub>J</sub> = 25°C		0.8	1.2	V
		I <sub>S</sub> = 15 A	T <sub>J</sub> = 125°C		0.66		1
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = 0$ V, dIS/dt = 100 A/ $\mu$ s, I <sub>S</sub> = 40 A			42		ns
Charge Time	t <sub>a</sub>				26		1
Discharge Time	t <sub>b</sub>				16		1
Reverse Recovery Charge	$Q_RR$				45		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.

5. Switching characteristics are independent of operating junction temperatures.

#### **TYPICAL CHARACTERISTICS**

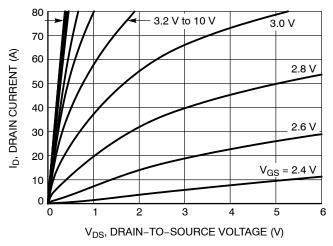


Figure 1. On-Region Characteristics

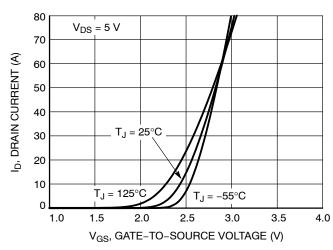


Figure 2. Transfer Characteristics

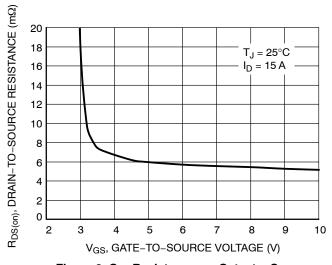


Figure 3. On-Resistance vs. Gate-to-Source Voltage

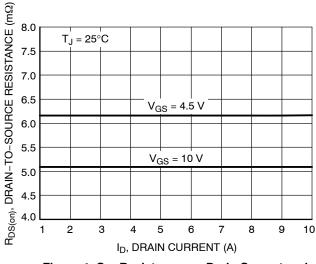


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

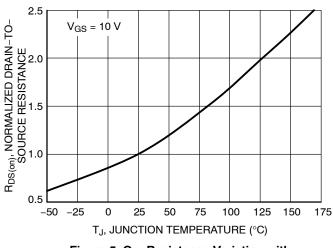


Figure 5. On–Resistance Variation with Temperature

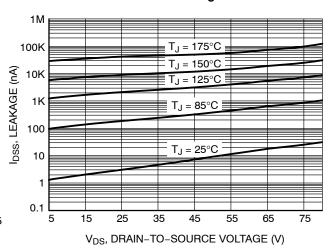


Figure 6. Drain-to-Source Leakage Current vs. Voltage

## TYPICAL CHARACTERISTICS (continued)

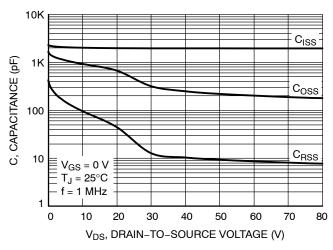


Figure 7. Capacitance Variation

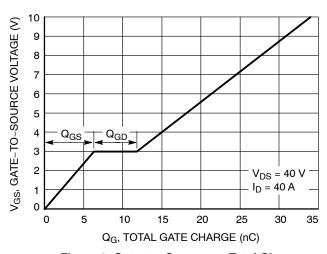


Figure 8. Gate-to-Source vs. Total Charge

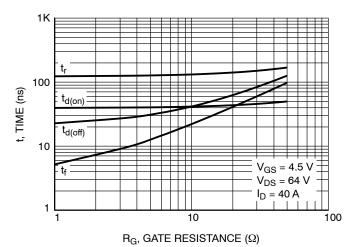


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

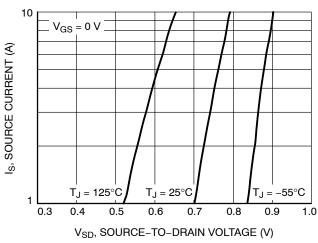


Figure 10. Diode Forward Voltage vs. Current

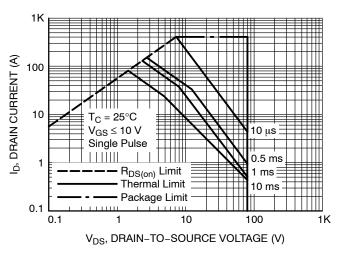


Figure 11. Maximum Rated Forward Biased Safe Operating Area

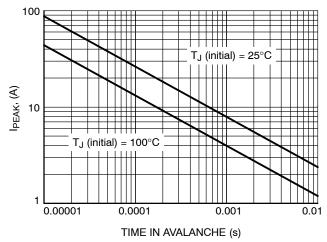


Figure 12. Maximum Drain Current vs. Time in Avalanche

## TYPICAL CHARACTERISTICS (continued)

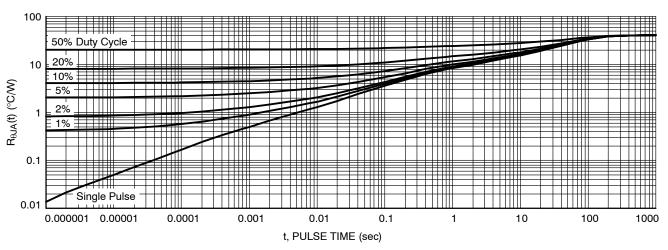


Figure 13. Thermal Response

## **DEVICE ORDERING INFORMATION**

Device	Marking	Package	Shipping <sup>†</sup>
NVMFS6H836NLT1G	6H836L	DFN5 (Pb-Free, Halide Free)	1500 / Tape & Reel
NVMFS6H836NLWFT1G	836LWF	DFNW5 (Pb-Free, Halide Free, Wettable Flanks)	1500 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, <a href="https://example.com/BRD8011/D">BRD8011/D</a>.





DFN5 5x6, 1.27P (SO-8FL) CASE 488AA **ISSUE N** 

**DATE 25 JUN 2018** 

#### NOTES:

- DIMENSIONING AND TOLERANCING PER
- ASME Y14.5M, 1994.
  2. CONTROLLING DIMENSION: MILLIMETER.
  3. DIMENSION D1 AND E1 DO NOT INCLUDE
- MOLD FLASH PROTRUSIONS OR GATE BURRS

	MILLIMETERS			
DIM	MIN	NOM	MAX	
Α	0.90	1.00	1.10	
A1	0.00		0.05	
b	0.33	0.41	0.51	
С	0.23	0.28	0.33	
D	5.00	5.15	5.30	
D1	4.70	4.90	5.10	
D2	3.80	4.00	4.20	
E	6.00	6.15	6.30	
E1	5.70	5.90	6.10	
E2	3.45	3.65	3.85	
е		1.27 BSC	;	
G	0.51	0.575	0.71	
K	1.20	1.35	1.50	
L	0.51	0.575	0.71	
L1	0.125 REF			
М	3.00	3.40	3.80	
θ	0 °		12 °	

#### **GENERIC MARKING DIAGRAM\***



XXXXXX = Specific Device Code

= Assembly Location Α

= Lot Traceability

Υ = Year W = Work Week

ZZ

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present. Some products may not follow the Generic Marking.





**DETAIL** A

SIDE VIEW

\*For additional information on our Pb-Free strategy and soldering details, please download the onsemi Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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DESCRIPTION:	DFN5 5x6, 1.27P (SO-8FL)		PAGE 1 OF 1	

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// 0.10 C

△ 0.10 C

#### DFNW5 4.90x5.90x1.00, 1.27P CASE 507BA **ISSUE C**

**DATE 19 SEP 2024** 





DETAIL A

SIDE VIEW

SEATING

PLANE





NO MOLD COMPOUND ON THE BOTTOM OF **DETAIL** TIE BAR. SCALE 2:1

#### NOTES:

- DIMENSIONING TOLERANCING TO ASME Y14.5M-2018.
- ALL DIMENSIONS ARE IN MILLIMETERS.
- .3. DIMENSIONS D1 AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.
- THIS PACKAGE CONTAINS WETTABLE FLANK DESIGN FEATURES TO AID IN FILLET FORMATION ON THE LEADS DURING MOUNTING.



MILLIMETERS

L	0.00	0.15	0.50	
E1	5.70	5.90	6.10	
E2	3.45	3.65	3.85	
E3	3.00	3.40	3.80	
е	1.27 BSC			
k	1.20	1.35	1.50	
L	0.51	0.57	0.71	
L2	0.15 REF.			
θ	0.	6,	12*	





RECOMMENDED MOUNTING FOOTPRINT\* \*FOR ADDITIONAL INFORMATION ON OUR PD-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ONSEMI SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

#### **GENERIC MARKING DIAGRAM\***



XXXXXX = Specific Device Code

= Assembly Location Α Υ = Year

W = Work Week ZZ = Lot Traceability \*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present. Some products may not follow the Generic Marking.

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